

KEY FEATURES

- High-speed access time: 45ns, 55ns
- CMOS low power operation
 - Operating Current: 35mA (max.)
 - CMOS standby Current: 5.5uA (typ.)
- TTL compatible interface levels
- Single power supply
 - -1.65V-2.2V VDD (IS62/65WV20488FALL)
 - 2.2V-3.6V VDD (IS62/65WV20488FBLL)
- Three state outputs
- Industrial and Automotive temperature support
- Lead-free available

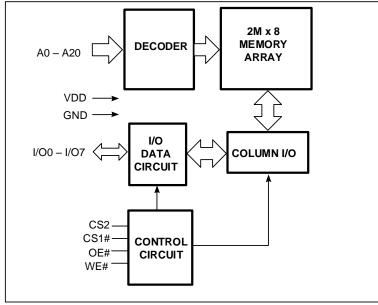
DESCRIPTION

The *ISSI* IS62/65WV20488FALL/BLL are high-speed, 16M bit static RAMs organized as 2M words by 8 bits. It is fabricated using *ISSI*'s high-performance CMOS technology. This highly reliable process coupled with innovative circuit design techniques, yields highperformance and low power consumption devices.

When CS1# is HIGH (deselected) or when CS2 is LOW (deselected), the device assumes a standby mode at which the power dissipation can be reduced down with CMOS input levels.

Easy memory expansion is provided by using Chip Enable and Output Enable inputs. The active LOW Write Enable (WE#) controls both writing and reading of the memory.

The IS62/65WV20488FALL/BLL are packaged in the JEDEC standard 48-pin mini BGA.



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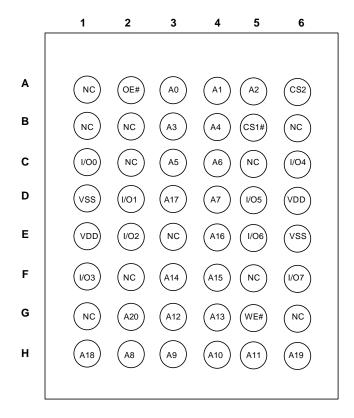


FUNCTIONAL BLOCK DIAGRAM

IS62WV20488FALL IS65WV20488FBLL

PIN CONFIGURATIONS

48-Pin mini BGA (6mm x 8mm)



PIN DESCRIPTIONS

A0-A20	Address Inputs
I/O0-I/O7	Data Inputs/Outputs
CS1#, CS2	Chip Enable Inputs
OE#	Output Enable Input
WE#	Write Enable Input
NC	No Connection
Vdd	Power
VSS	Ground





FUNCTION DESCRIPTION

SRAM is one of random access memories. SRAM has three different modes supported. Each function is described below with Truth Table.

STANDBY MODE

Device enters standby mode when deselected (CS1# HIGH or CS2 LOW). The input and output pins (I/O0-7) are placed in a high impedance state. CMOS input in this mode will maximize saving power.

WRITE MODE

Write operation issues with Chip selected (CS1# LOW and CS2 HIGH) and Write Enable (WE#) input LOW. The input and output pins (I/O0-7) are in data input mode. Output buffers are closed during this time even if OE# is LOW.

READ MODE

Read operation issues with Chip selected (CS1# LOW and CS2 HIGH) and Write Enable (WE#) input HIGH. When OE# is LOW, output buffer turns on to make data output. Any input to I/O pins during READ mode is not permitted.

In the READ mode, output buffers can be turned off by pulling OE# HIGH. In this mode, internal device operates as READ but I/Os are in a high impedance state. Since device is in READ mode, active current is used.

TRUTH TABLE

Mode	CS1#	CS2	WE#	OE#	I/O0-I/O7	VDD Current
Not Selected	Н	Х	Х	Х	High-Z	ISB2
NUL Selected	Х	L	Х	Х	High-Z	ISB2
Output Disabled	L	Н	Н	Н	High-Z	ICC,ICC1
Write	L	Н	L	Х	DIN	ICC,ICC1
Read	L	Н	Н	L	DOUT	ICC,ICC1



ABSOLUTE MAXIMUM RATINGS AND OPERATING RANGE

ABSOLUTE MAXIMUM RATINGS⁽¹⁾

Symbol	Parameter	Value	Unit
Vterm	Terminal Voltage with Respect to GND	–0.5 to V _{DD} + 0.5	V
Vdd	V _{DD} Related to GND	–0.3 to 4.0	V
tStg	Storage Temperature	-65 to +150	°C
PT	Power Dissipation	1.0	W

Notes:

1. Stress greater than those listed under ABSOLUTE MAXIMUM RATINGS may cause permanent damage to the device. This is a stress rating only and functional operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect reliability.

OPERATING RANGE⁽¹⁾

Range	Ambient Temperature	PART NUMBER	SPEED (MAX)	VDD(MIN)	VDD(TYP)	VDD(MAX)
Commercial	0°C to +70°C		55 ns	1.65V	1.8V	2.2V
Industrial	-40°C to +85°C	~ALL	55 ns	1.65V	1.8V	2.2V
Automotive	-40°C to +125°C		55 ns	1.65V	1.8V	2.2V
Commercial	0°C to +70°C		45ns	2.2V	3.0V	3.6V
Industrial	-40°C to +85°C	~BLL	45ns	2.2V	3.0V	3.6V
Automotive	-40°C to +125°C]	55ns	2.2V	3.0V	3.6V

Note:

1. Full device AC operation assumes a 100 µs ramp time from 0 to Vcc(min) and 200 µs wait time after Vcc stabilization.

PIN CAPACITANCE ⁽¹⁾

Parameter	Symbol	Test Condition	Max	Units
Input capacitance	CIN		6	pF
DQ capacitance (IO0–IO7)	C _{I/O}	$T_A = 25^{\circ}C$, f = 1 MHz, $V_{DD} = V_{DD}(typ)$	8	pF

Note:

2. These parameters are guaranteed by design and tested by a sample basis only.

THERMAL CHARACTERISTICS (1)

Parameter	Symbol	Test Conditions	48-ball BGA	Units
Thermal resistance (junction to ambient)	Reja		48.4	°C/W
Thermal resistance (junction to pins)	R _{θJB}	Still air, four-layer printed circuit board	23.3	°C/W
Thermal resistance (junction to case)	Rejc	printed circuit board	10.8	°C/W

Note:

1. These parameters are guaranteed by design and tested by a sample basis only.

AC TEST CONDITIONS (OVER THE OPERATING RANGE)

Parameter	Unit (1.65V~2.2V)	Unit (2.2V~3.6V)		
Input Pulse Level	0V to V _{DD}	0V to V _{DD}		
Input Rise and Fall Time	1V/ns	1V/ns		
Output Timing Reference Level	0.9V	1/2 V _{DD}		
R1	13500	1005		
R2	10800	820		
VTM	1.8V	V _{DD}		
Output Load Conditions	Refer to Figure 1 and 2			

OUTPUT LOAD CONDITIONS FIGURES

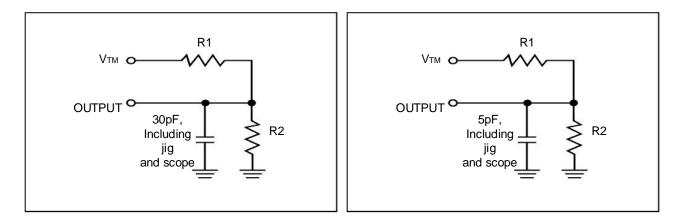


FIGURE 2

FIGURE 1



DC ELECTRICAL CHARACTERISTICS

IS62(5)WV20488FALL DC ELECTRICAL CHARACTERISTICS- I (OVER THE OPERATING RANGE) VDD = 1.65V \sim 2.2V

Symbol	Parameter	Test Conditions	Min.	Max.	Unit
Vон	Output HIGH Voltage	lон = -0.1 mA	1.4	—	V
Vol	Output LOW Voltage	I _{OL} = 0.1 mA	—	0.2	V
V _{IH} ⁽¹⁾	Input HIGH Voltage		1.4	V _{DD} + 0.2	V
VIL ⁽¹⁾	Input LOW Voltage		-0.2	0.4	V
ILI	Input Leakage	GND < V _{IN} < V _{DD}	-1	1	μA
ILO	Output Leakage	GND < V _{IN} < V _{DD} , Output Disabled	-1	1	μA

Notes:

1. VILL(min) = -1.0V AC (pulse width < 10ns). Not 100% tested.

VIHH (max) = VDD + 1.0V AC (pulse width < 10ns). Not 100% tested.

IS62(5)WV20488FBLL DC ELECTRICAL CHARACTERISTICS- I (OVER THE OPERATING RANGE) VDD = 2.2V ~ 3.6V

Symbol	Parameter	Test Conditions	Min.	Max.	Unit
Vон	Output HIGH Voltage	2.2 ≤ V _{DD} < 2.7, I _{OH} = -0.1 mA	2.0	—	V
		2.7 ≤ V _{DD} ≤ 3.6, I _{OH} = -1.0 mA	2.4		V
Vol	Output LOW Voltage	$2.2 \le V_{DD} < 2.7, I_{OL} = 0.1 \text{ mA}$		0.4	V
		$2.7 \le V_{DD} \le 3.6$, $I_{OL} = 2.1 \text{ mA}$		0.4	V
V _{IH} ⁽¹⁾	Input HIGH Voltage	$2.2 \le V_{DD} < 2.7$	1.8	V _{DD} + 0.3	V
		$2.7 \le V_{DD} \le 3.6$	2.0	V _{DD} + 0.3	V
VIL ⁽¹⁾	Input LOW Voltage	$2.2 \le V_{DD} < 2.7$	-0.3	0.6	V
		$2.7 \le V_{DD} \le 3.6$	-0.3	0.8	V
L	Input Leakage	GND < VIN < VDD	-1	1	μA
Ilo	Output Leakage	GND < V _{IN} < V _{DD} , Output Disabled	-1	1	μA

Notes:

1. VILL(min) = -2.0V AC (pulse width < 10ns). Not 100% tested.

VIHH (max) = VDD + 2.0V AC (pulse width < 10ns). Not 100% tested.



IS62(5)WV20488FALL DC ELECTRICAL CHARACTERISTICS-II FOR POWER (OVER THE OPERATING RANGE)

Symbol	Parameter	Test Conditions	Grade		Typ ⁽¹⁾	Мах	Unit
	V _{DD} Dynamic		Cor	n.	-	35	
ICC	Operating Supply	$V_{DD} = V_{DD}(max), I_{OUT} = 0mA,$ f = f _{max} .	Inc	ł.	-	35	mA
	Current	r – imax,	Auto.	. A3	-	35	
	V _{DD} Static		Com.		-	5	
ICC1 Operating Supply	$V_{DD} = V_{DD}(max), I_{OUT} = 0mA,$ f = 0	Ind.		-	5	mA	
	Current	1 = 0	Auto. A3		-	5	
				25°C	5.5	9(2)	
	CMOS Standby	$V_{DD} = V_{DD}(max), f = 0,$	Com.	40°C	6.0	10 ⁽²⁾	
ISB2	Current (CMOS	CS1# ≥ V _{DD} - 0.2V or CS2 < 0.2V,		70°C	7.5	14	μA
Inputs)	Inputs)	$VIN \le 0.2V$ or $VIN \ge V_{DD} - 0.2V$	Ind.	85°C	10.5	20	
			Auto. A3	125°C	25	55	

Notes:

1. Typical value indicates the value for the center of distribution at VDD=VDD (Typ.), and not 100% tested.

2. Maximum value at 25°C, 40°C are guaranteed by design, and not 100% tested

IS62(5)WV20488FBLL DC ELECTRICAL CHARACTERISTICS-II FOR POWER (OVER THE OPERATING RANGE)

Symbol	Parameter	Test Conditions	Grade		Typ ⁽¹⁾	Мах	Unit
	V _{DD} Dynamic	$V_{DD} = V_{DD}(max), I_{OUT} = 0mA,$	Cor	m.	-	35	
ICC	Operating Supply	$f = f_{max}$	Inc	J.	-	35	mA
	Current	1 — Tillax,	Auto	. A3	-	35	
	V _{DD} Static	atic V V (max) I Om A		m.	-	5	
ICC1	ICC1 Operating Supply	$V_{DD} = V_{DD}(max), I_{OUT} = 0mA,$ f = 0	Ind.		-	5	mA
	Current	1 - 0	Auto. A3		-	5	
				25°C	5.5	9 ⁽²⁾	
	CMOS Standby	$V_{DD} = V_{DD}(max), f = 0,$	Com.	40°C	6.0	10 ⁽²⁾	
ISB2	Current (CMOS	CS1# ≥ V _{DD} - 0.2V or CS2 < 0.2V,		70°C	7.5	14	μA
Inputs)	Inputs)	$VIN \le 0.2V$ or $VIN \ge V_{DD} - 0.2V$	Ind.	85°C	10.5	20	
			Auto. A3	125°C	25	55	

Notes:

1. Typical value indicates the value for the center of distribution at V_{DD}=V_{DD} (Typ.), and not 100% tested.

2. Maximum value at 25°C, 40°C are guaranteed by design, and not 100% tested.



AC CHARACTERISTICS⁽⁶⁾ (OVER OPERATING RANGE)

READ CYCLE AC CHARACTERISTICS

Parameter	Symbol	45	ns	55	ns	unit	notes
Farameter	Symbol	Min	Max	Min	Max	unit ns ns ns ns ns ns ns ns ns ns	notes
Read Cycle Time	tRC	45	-	55	-	ns	1,5
Address Access Time	tAA	-	45	-	55	ns	1
Output Hold Time	tOHA	10	-	10	-	ns	1
CS1#, CS2 Access Time	tACS1/ACS2	-	45	-	55	ns	1
OE# Access Time	tDOE	-	20	-	25	ns	1
OE# to High-Z Output	tHZOE	-	15	-	20	ns	2
OE# to Low-Z Output	tLZOE	5	-	5	-	ns	2
CS1#, CS2 to High-Z Output	tHZCS1/HZCS2	-	15	-	20	ns	2
CS1#, CS2 to Low-Z Output	tLZCS/LZCS2	10	-	10	-	ns	2

WRITE CYCLE AC CHARACTERISTICS

Parameter	Symbol	45ns		55ns		unit	notos
Farameter		Min	Max	Min	Min	umit	notes
Write Cycle Time	tWC	45	-	55	-	ns	1,3,5
CS1#, CS2 to Write End	tSCS1/SCS2	35	-	40	-	ns	1,3
Address Setup Time to Write End	tAW	35	-	40	-	ns	1,3
Address Hold from Write End	tHA	0	-	0	-	ns	1,3
Address Setup Time	tSA	0	-	0	-	ns	1,3
WE# Pulse Width	tPWE	35	-	40	-	ns	1,3,4
Data Setup to Write End	tSD	20	-	25	-	ns	1,3
Data Hold from Write End	tHD	0	-	0	-	ns	1,3
WE# LOW to High-Z Output	tHZWE	-	15	-	20	ns	2,3
WE# HIGH to Low-Z Output	tLZWE	5	-	5	-	ns	2,3

Notes:

1. Tested with the load in Figure 1.

Tested with the load in Figure 2. Transition is measured ±500 mV from steady-state voltage. tHZOE, tHZCS, tHZB, and tHZWE transitions are measured when the output enters a high impedance state. Not 100% tested.
The internal write time is defined by the overlap of CS1# = LOW, CS2=HIGH, and WE# = LOW. All four conditions must be in valid states to

3. The internal write time is defined by the overlap of CS1# = LOW, CS2=HIGH, and WE# = LOW. All four conditions must be in valid states to initiate a Write, but any condition can go inactive to terminate the Write. The Data Input Setup and Hold timing are referenced to the rising or falling edge of the signal that terminates the write.

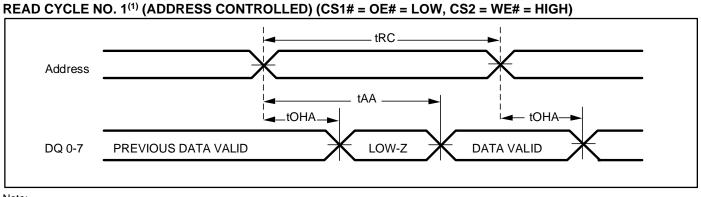
4. tPWE > tHZWE + tSD when OE# is LOW.

5. Address inputs must meet V_{IH} and V_{IL} SPEC during this period. Any glitch or unknown inputs are not permitted. Unknown input with standby mode is acceptable.

6. Data retention characteristics are defined later in DATA RETENTION CHARACTERISTICS.

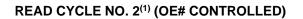


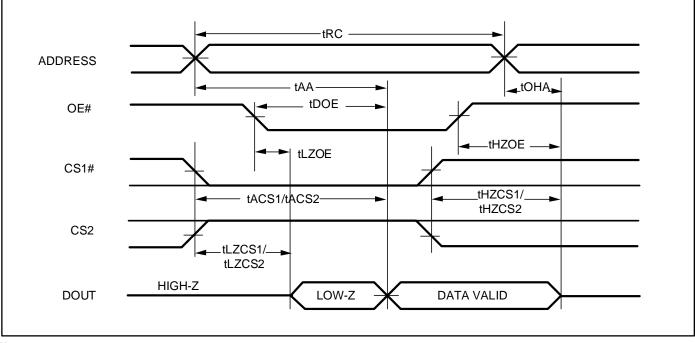
TIMING DIAGRAM



Note:

1. The device is continuously selected.





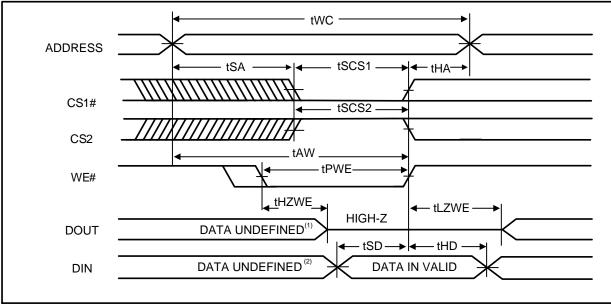
Note:

1. Address is valid prior to or coincident with CS1# LOW and CS2 HIGH transition.

IS62WV20488FALL IS65WV20488FBLL



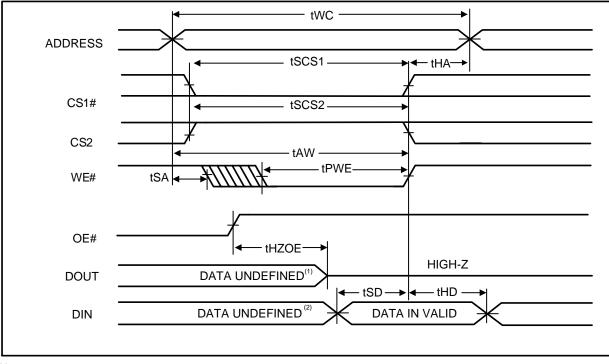
WRITE CYCLE 1^(1, 2) (CS1#, CS2 Controlled, OE# = HIGH or LOW)



Notes:

- 1. tHZWE is based on the assumption when tSA=0nS after READ operation. Actual DOUT for tHZWE may not appear if OE# goes high before Write Cycle. tHZOE is the time DOUT goes to High-Z after OE# goes high
- During this period the I/Os are in output state. Do not apply input signals.

WRITE CYCLE NO. 2^(1,2) (WE# CONTROLLED: OE# IS HIGH DURING WRITE CYCLE)



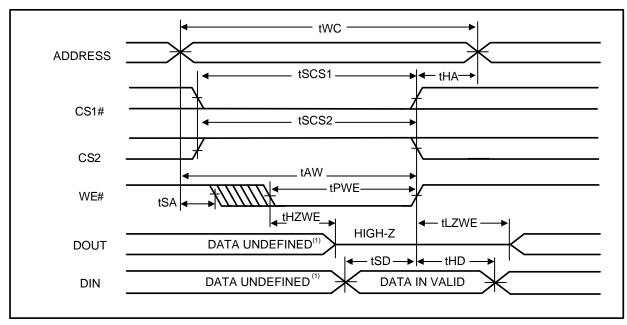
Notes:

2. During this period the I/Os are in output state. Do not apply input signals.

^{1.} tHZOE is the time DOUT goes to High-Z after OE# goes high.



WRITE CYCLE NO. 3⁽¹⁾ (WE# CONTROLLED: OE# IS LOW DURING WRITE CYCLE)



Note:

1. If OE# is low during write cycle, tHZWE must be met in the application. Do not apply input signal during this period. Data output from the previous READ operation will drive IO BUS.



DATA RETENTION CHARACTERISTICS

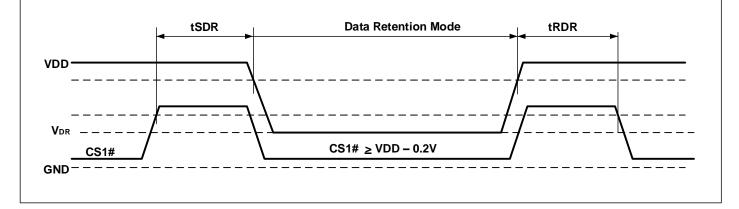
Symbol	Parameter	Test Condition		Min.	Тур. ⁽¹⁾	Max.	Unit
V_{DR}	V _{DD} for Data Retention	See Data Retention Waveform		1.5	-	-	V
IDR Data Retention Current	() (min)	25°C	-	5.5	13		
	Data Retention Current	$V_{DD} = V_{DR}$ (min), CS1# $\geq V_{DD} - 0.2V$ or CS2 $\leq 0.2V$ VIN $\leq 0.2V$ or VIN $\geq V_{DD} - 0.2V$	85°C	-	-	19	uA
		125°C	-	-	52		
t _{SDR} ⁽²⁾	Data Retention Setup Time	See Data Retention Waveform		0	-	-	ns
t RDR	Recovery Time	See Data Retention Waveform		tRC	-	-	ns

Notes:

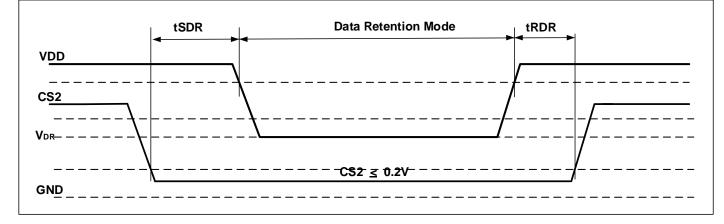
1. Typical value indicates the value for the center of distribution at $V_{DD} = V_{DR}$ (min.), and not 100% tested.

2. VDD power down slope must be longer than 100 us/volt when enter into Data Retention Mode.

DATA RETENTION WAVEFORM (CS1# CONTROLLED)



DATA RETENTION WAVEFORM (CS2 CONTROLLED)





ORDERING INFORMATION

IS62/65WV20488FALL (1.65V - 2.2V)

Industrial Range: -40°C to +85°C

Speed (ns)	Order Part No.	Package
55	IS62WV20488FALL-55BI	mini BGA (6mm x 8mm)
55	IS62WV20488FALL-55BLI	mini BGA (6mm x 8mm), Lead-free

AUTOMOTIVE RANGE (A3): -40°C TO +125°C

Speed (ns)	Order Part No.	Package
55	IS65WV20488FALL-55BA3	mini BGA (6mm x 8mm)
55	IS65WV20488FALL-55BLA3	mini BGA (6mm x 8mm), Lead-free

IS62/65WV20488BLL (2.2V - 3.6V)

Industrial Range: -40°C to +85°C

Speed (ns)	Order Part No.	Package
45	IS62WV20488FBLL-45BI	mini BGA (6mm x 8mm)
45	IS62WV20488FBLL-45BLI	mini BGA (6mm x 8mm), Lead-free
55	IS62WV20488FBLL-55BI	mini BGA (6mm x 8mm)
55	IS62WV20488FBLL-55BLI	mini BGA (6mm x 8mm), Lead-free

Automotive Range (A3): -40°C to +125°C

Speed (ns)	Order Part No.	Package
55	IS65WV20488FBLL-55BA3	mini BGA (6mm x 8mm)
55	IS65WV20488FBLL-55BLA3	mini BGA (6mm x 8mm), Lead-free